CD74HCT574-Q1 HIGH-SPEED CMOS LOGIC OCTAL D-TYPE FLIP-FLOP 3-STATE, POSITIVE-EDGE TRIGGERED

SCLS570A – FEBRUARY 2004 – REVISED APRIL 2008

- Qualified for Automotive Applications
- Buffered Inputs
- Common 3-State Output-Enable Control
- 3-State Outputs
- Bus-Line Driving Capability
- Typical Propagation Delay (Clock to Q): 15 ns at V_{CC} = 5 V, C_L = 15 pF, T_A = 25°C
- Fanout (Over Temperature Range)
 Standard Outputs ... 10 LSTTL Loads
 - Bus Driver Outputs ... 15 LSTTL Loads
- Balanced Propagation Delay and Transition Times

description/ordering information

The CD74HCT574 is an octal D-type flip-flop with 3-state outputs and the capability to drive 15 LSTTL loads. The eight edge-triggered flip-flops enter data into their registers on the low-to-high transition of the clock (CP). The output enable (\overline{OE}) controls the 3-state outputs and is independent of the register operation. When \overline{OE} is high, the outputs are in the high-impedance state.

- Significant Power Reduction Compared to LSTTL Logic ICs
- V_{CC} Voltage = 4.5 V to 5.5 V
- Direct LSTTL Input Logic Compatibility, V_{IL} = 0.8 V (Max), V_{IH} = 2 V (Min)
- CMOS Input Compatibility, II \leq 1 μ A at V_{OL}, V_{OH}

	M OR PW PACKAGE (TOP VIEW)											
OE [D0 [D1 [D2 [D3 [D4 [D5 [D6 [D7 [GND [1 2 3 4 5 6 7 8 9 10	σ	20 19 18 17 16 15 14 13 12 11	V _{CC} Q0 Q1 Q2 Q3 Q4 Q5 Q7 CP								
5D L				۲ ۲								

ORDERING INFORMATION[†]

TA	PACK	AGE [‡]	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125°C	SOIC – M	Tape and reel	CD74HCT574QM96Q1	HCT574Q
	TSSOP – PW	Tape and reel	CD74HCT574QPWRQ1	HCT574Q

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.



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	FUNCTION TABLE												
	INPUTS	OUTPUT											
OE	СР	D	Q										
L	\uparrow	Н	Н										
L	\uparrow	L	L										
L	L	Х	Q ₀										
Н	Х	Х	Z										

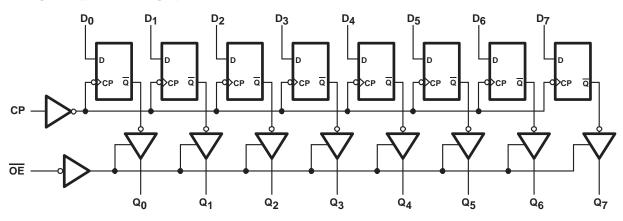
NOTE: H = High voltage level (steady state)

L = Low voltage level (steady state) X = Don't care

 \uparrow = Transition from low to high level Q_0 = Level before the indicated steady-state conditions were established

Z = High-impedance state

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC} (see Note 1) Input clamp current, I_{IK} ($V_I < -0.5$ V or $V_I > V_{CC} + 0.5$ V) Output clamp current, I_{OK} ($V_O < -0.5$ V or $V_O > V_{CC} + 0.5$ V) Drain current per output, I_O ($V_O > -0.5$ V or $V_O < V_{CC} + 0.5$ V) Output source or sink current per output, I_O ($V_O > -0.5$ V or $V_O < V_{CC} + 0.5$ V) Continuous current through V_{CC} or GND, I_{CC}	±20 mA ±20 mA ±35 mA ±25 mA ±50 mA
Package thermal impedance, θ_{JA} (see Note 2): M package	
PW package	
Maximum junction temperature, T _J	150°C
Lead temperature (during soldering):	
At distance 1/16 \pm 1/32 inch (1,59 \pm 0,79 mm) from case for 10 s max $\ldots\ldots\ldots\ldots$	300°C
Storage temperature range, T _{stg}	õ5°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages referenced to GND unless otherwise specified.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	V
VIH	High-level input voltage $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2		V
VIL	Low-level input voltage $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		0.8	V
VI	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
	$V_{CC} = 2 V$	0	1000	
t _t	Input transition (rise and fall) time $V_{CC} = 4.5 V$	0	500	ns
	V _{CC} = 6 V	0	400	
ТА	Operating free-air temperature	-40	125	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	lo	Vcc	т,	₄ = 25°C	0	T _A = - TO 12	UNIT			
			(mA)		MIN	TYP	MAX	MIN	MAX		
N/	V V mV	CMOS loads	-0.02	4.5 V	4.4			4.4		V	
VOH	$V_I = V_{IH} \text{ or } V_{IL}$	TTL loads	-6	4.5 V	3.98			3.7		V	
		CMOS loads	0.02	4.5 V			0.1		0.1		
VOL	$V_I = V_{IH} \text{ or } V_{IL}$	TTL loads	6	4.5 V			0.26		0.4	V	
lj	$V_I = V_{CC} \text{ or } GND$		0	5.5 V			±0.1		±1	μA	
I _{OZ}	$V_I = V_{IL} \text{ or } V_{IH},$	$V_{O} = V_{CC} \text{ or } GND$		6 V			±0.5		±10	μA	
ICC	$V_I = V_{CC} \text{ or } GND$		0	5.5 V			8		160	μA	
ΔICC	$V_{I} = V_{CC} - 2.1 V,$	See Note 4		4.5 V to 5.5 V		100	360		490	μΑ	
C _{IN}	CL = 50 pF						10		10	pF	
COUT	3-state						20		20	pF	

NOTE 4: For dual-supply systems, theoretical worst-case (VI = 2.4 V, V_{CC} = 5.5 V) specification is 1.8 mA.

HCT input loading

INPUT	UNIT LOADS [†]				
D0-D7	0.4				
CP	0.75				
OE	0.6				
	D0-D7 CP				

[†]Unit load is ΔI_{CC} limit specified in electrical characteristics table, e.g., 360 µA max at 25°C.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

	PARAMETER	Vcc	T _A = 2	25°C	T _A = - TO 12	UNIT	
			MIN	MAX	MIN	MAX	
fmax	Maximum clock frequency	4.5 V	30		20		MHz
tw	Clock pulse duration	4.5 V	16		24		ns
t _{su}	Setup time, data before clock↑	4.5 V	12		18		ns
th	Hold time, data after clock↑	4.5 V	5		5		ns



CD74HCT574-Q1 HIGH-SPEED CMOS LOGIC OCTAL D-TYPE FLIP-FLOP 3-STATE, POSITIVE-EDGE TRIGGERED SCLS570A - FEBRUARY 2004 - REVISED APRIL 2008

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO	LOAD	v _{cc}	Т	ע = 25°C	;	T _A = - TO 12		UNIT	
	(INPUT)	(OUTPUT)	CAPACITANCE		MIN	TYP	MAX	MIN	MAX		
	<u>CP</u>	0	CL = 50 pF	4.5 V			33		50		
^t pd	od CP	Q	CL = 15 pF	5 V		15				ns	
4	OE	Q -	CL = 50 pF	4.5 V			28		42		
^t dis	OE		CL = 15 pF	5 V		11				ns	
	OE		C _L = 50 pF	4.5 V			30		45		
t _{en}	ÛE	Q	CL = 15 pF	5 V		12				ns	
tt		Q	C _L = 50 pF	4.5 V			12		18	ns	
fmax	СР		C _L = 15 pF	5 V		60				MHz	

operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$, input t_r , $t_f = 6 ns$

PARAMETER	TYP	UNIT
C _{pd} Power dissipation capacitance (see Note 5)	47	pF
NOTE 5: C_{1} is used to determine the dynamic network consumption (P_{-}) has neckage		

NOTE 5: C_{pd} is used to determine the dynamic power consumption (P_D), per package. P_D = (C_{PD} × V_{CC}² × f_l) + Σ (C_L × V_{CC}² × f_O)

f_I = input frequency

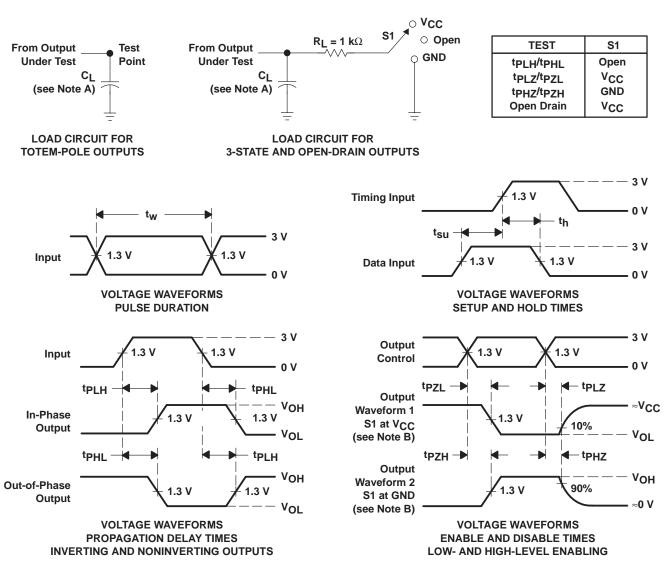
 f_{O} = output frequency C_L = output load capacitance

 V_{CC} = supply voltage



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SCLS570A - FEBRUARY 2004 - REVISED APRIL 2008



PARAMETER MEASUREMENT INFORMATION

NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_Q = 50 Ω , t_r \leq 6 ns, t_f \leq 6 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.
- F. t_{PLH} and t_{PHL} are the same as t_{pd} .
- G. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- H. t_{PZH} and t_{PZL} are the same as t_{en} .
 - Figure 1. Load Circuit and Voltage Waveforms





10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HCT574QM96G4Q1	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT574Q1	Samples
CD74HCT574QPWRG4Q1	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT574Q1	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

10-Dec-2020

OTHER QUALIFIED VERSIONS OF CD74HCT574-Q1 :

- Catalog: CD74HCT574
- Enhanced Product: CD74HCT574-EP
- Military: CD54HCT574

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications

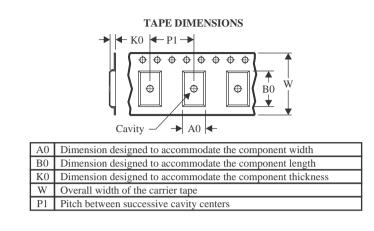


Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



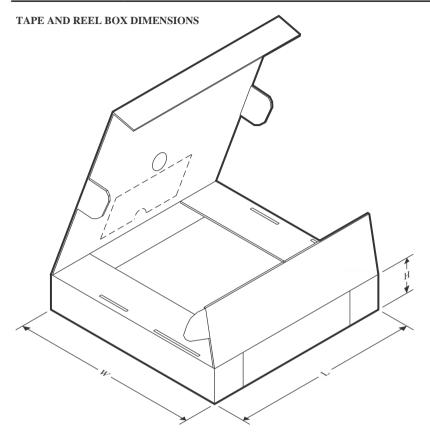
*All dimensions are nominal												
Device	•	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HCT574QM96G4Q1	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74HCT574QPWRG4Q1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1



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PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HCT574QM96G4Q1	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HCT574QPWRG4Q1	TSSOP	PW	20	2000	356.0	356.0	35.0

DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



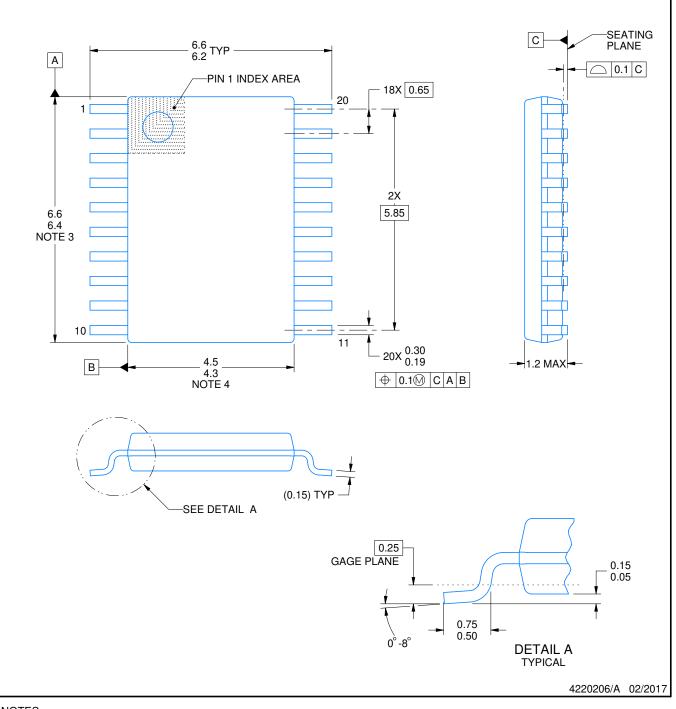
PW0020A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

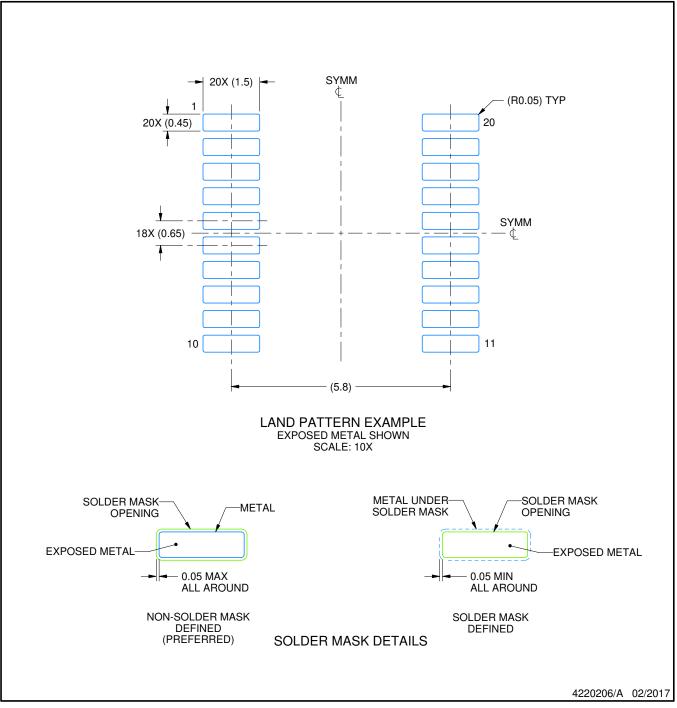


PW0020A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0020A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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